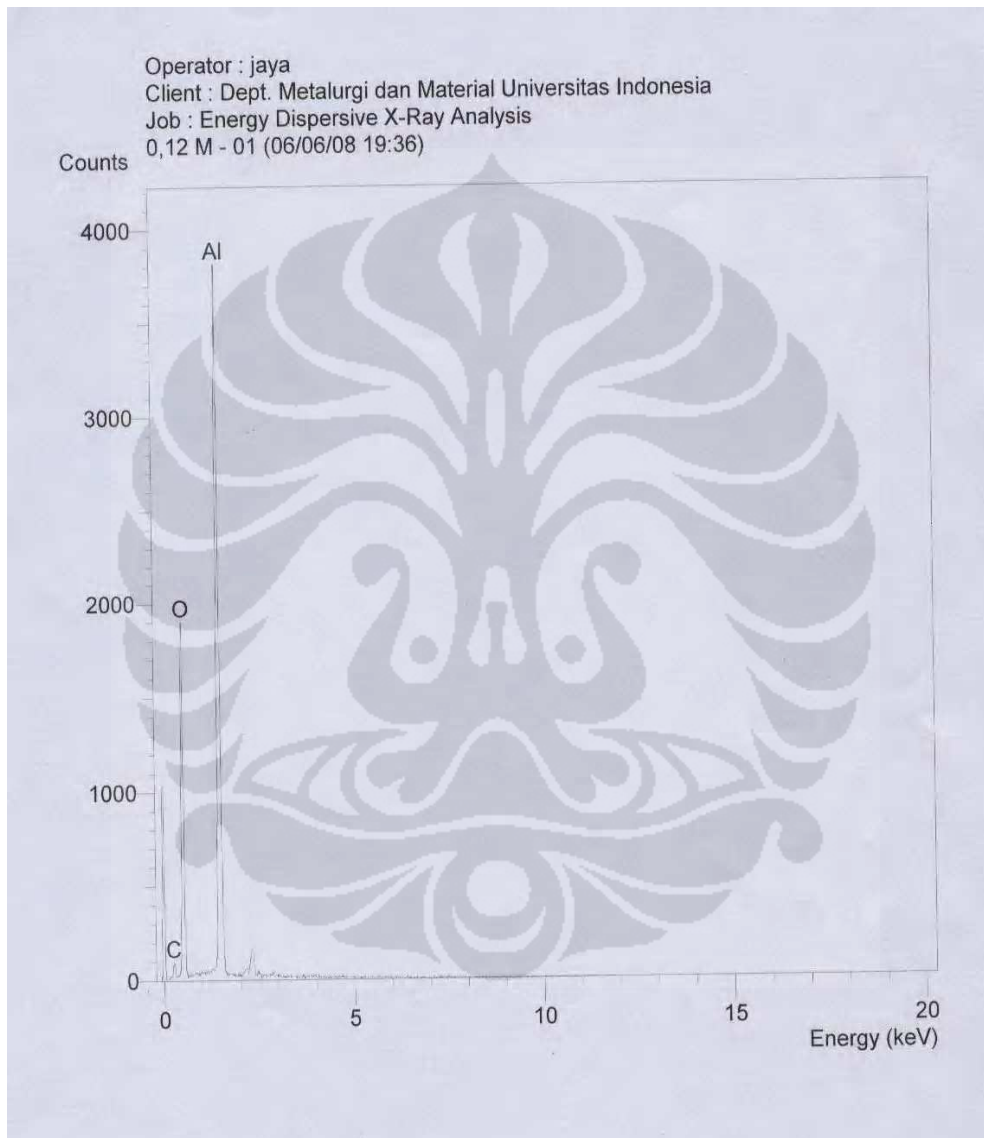
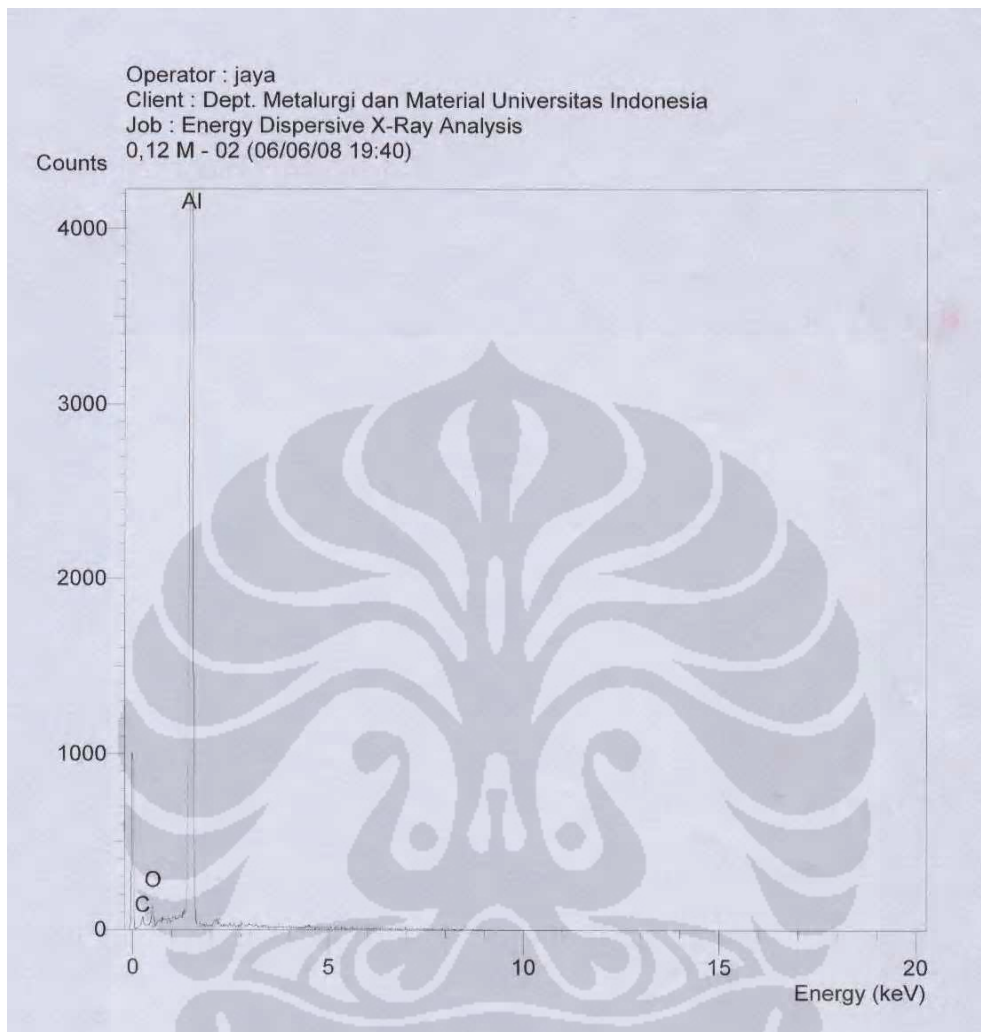


LAMPIRAN

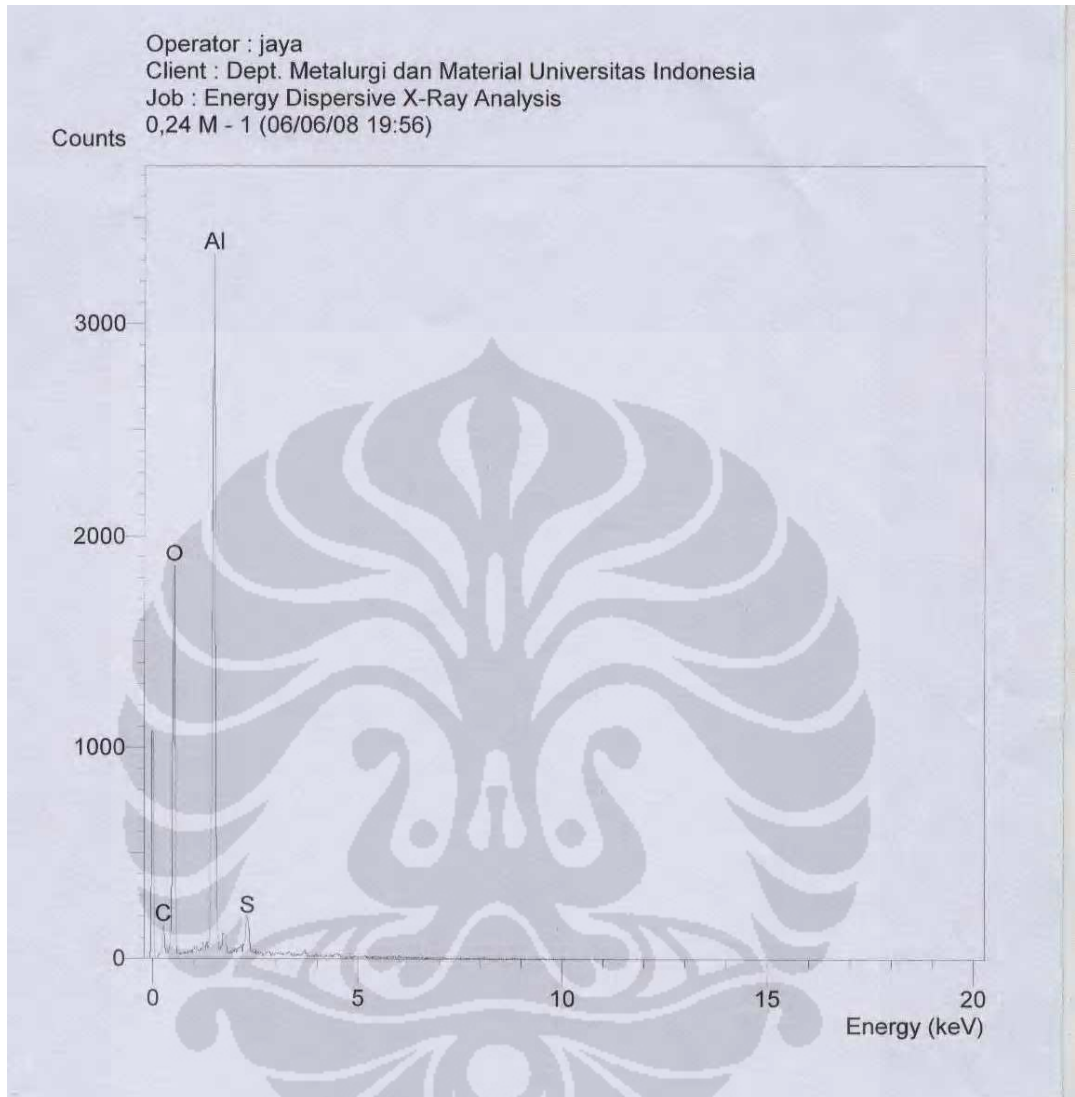
Lampiran 1. Kurva EDX sample hasil percobaan dengan penambahan 0,12 M Asam Sulfat (Bagian Lapisan Oksida)



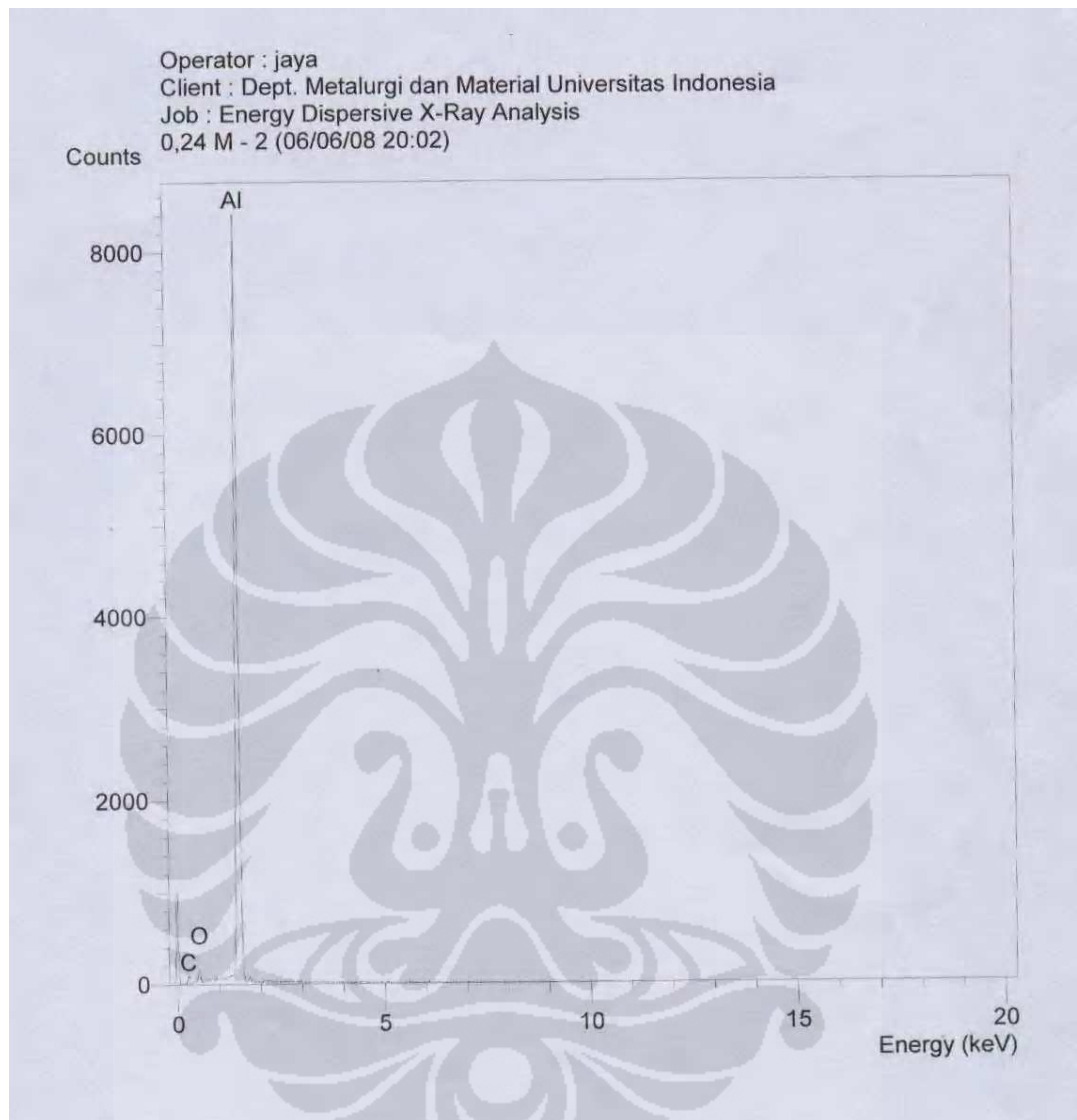
Lampiran 2. Kurva EDX sample hasil percobaan dengan penambahan 0,12 M Asam Sulfat (Bagian *Base Metal*)



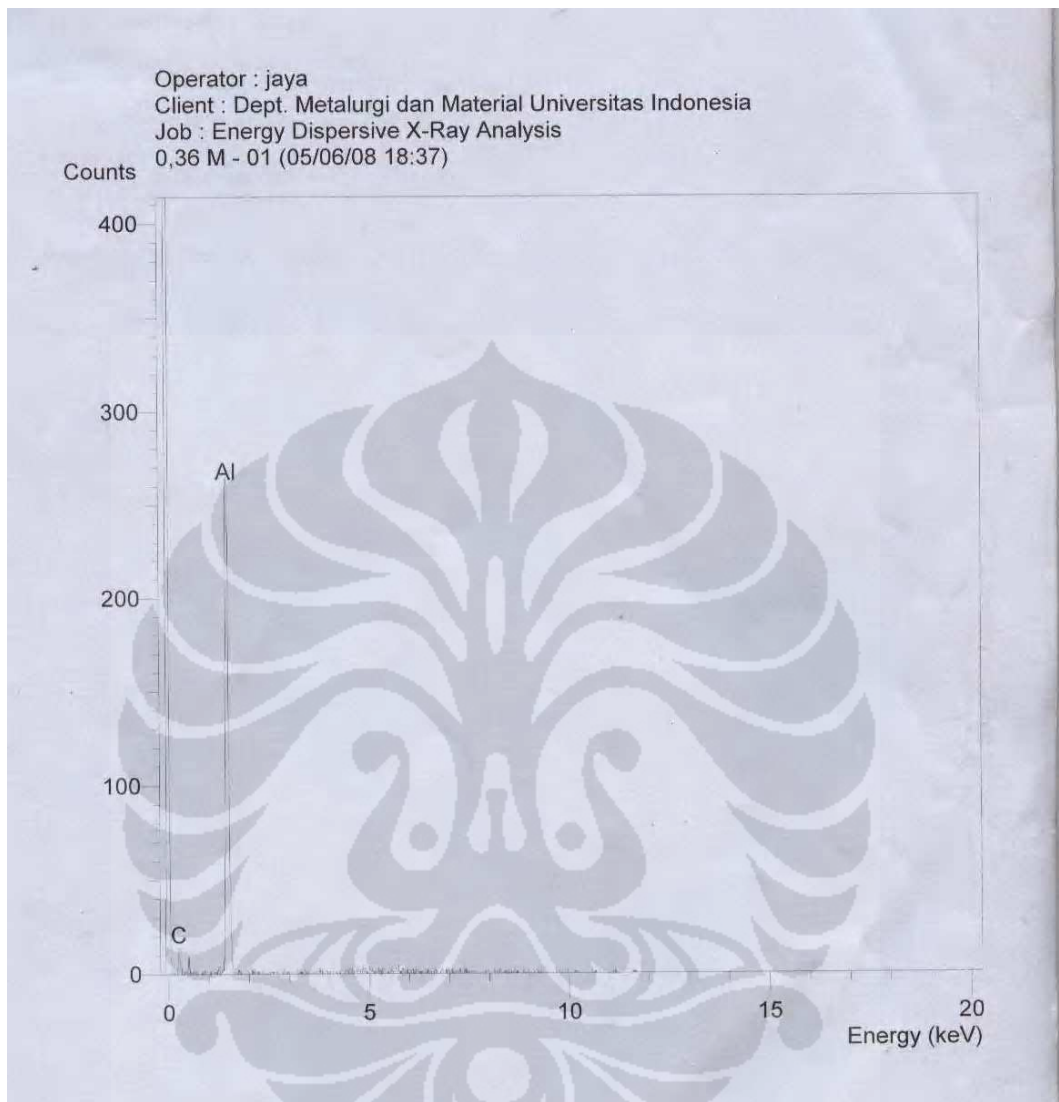
Lampiran 3. Kurva EDX sample hasil percobaan dengan penambahan 0,24 M Asam Sulfat (Bagian Lapisan Oksida)



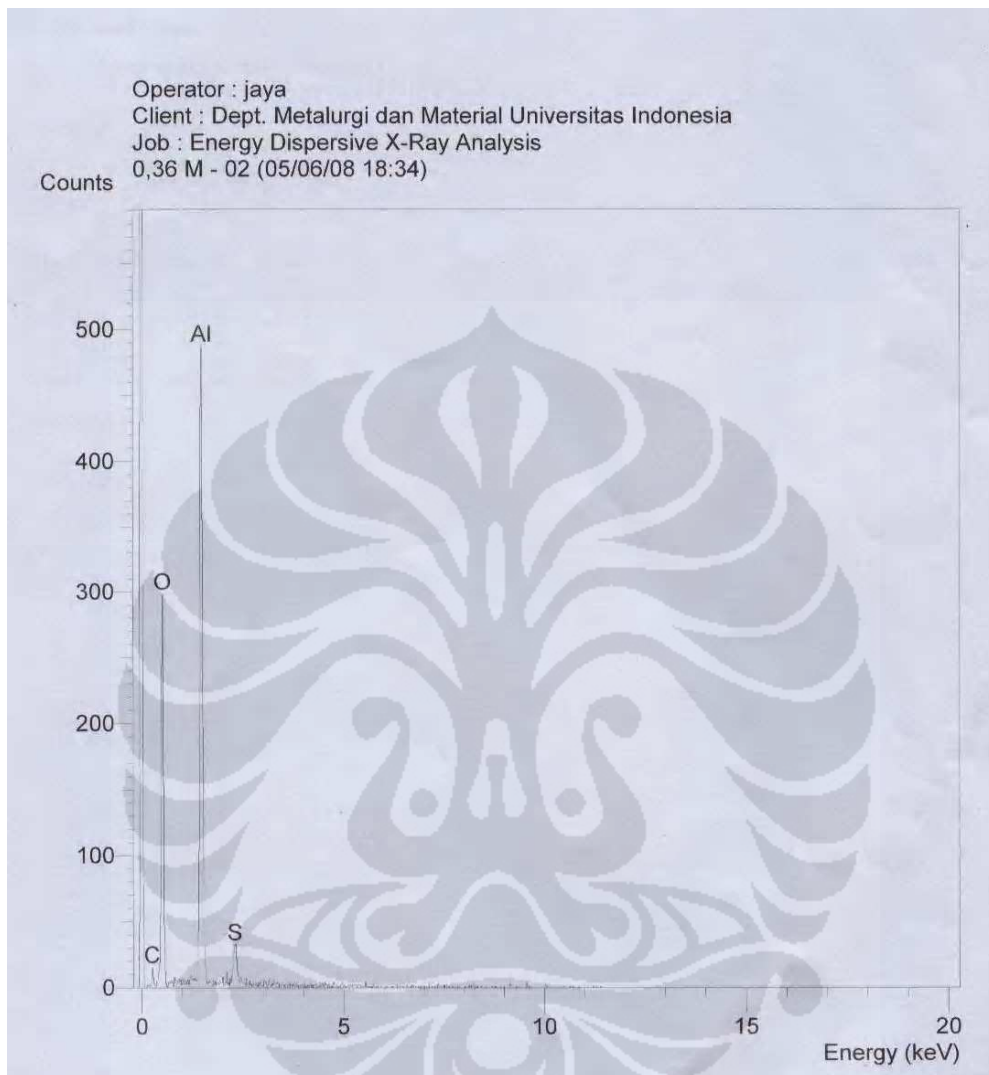
Lampiran 4. Kurva EDX sample hasil percobaan dengan penambahan 0,24 M Asam Sulfat (Bagian *Base Metal*)



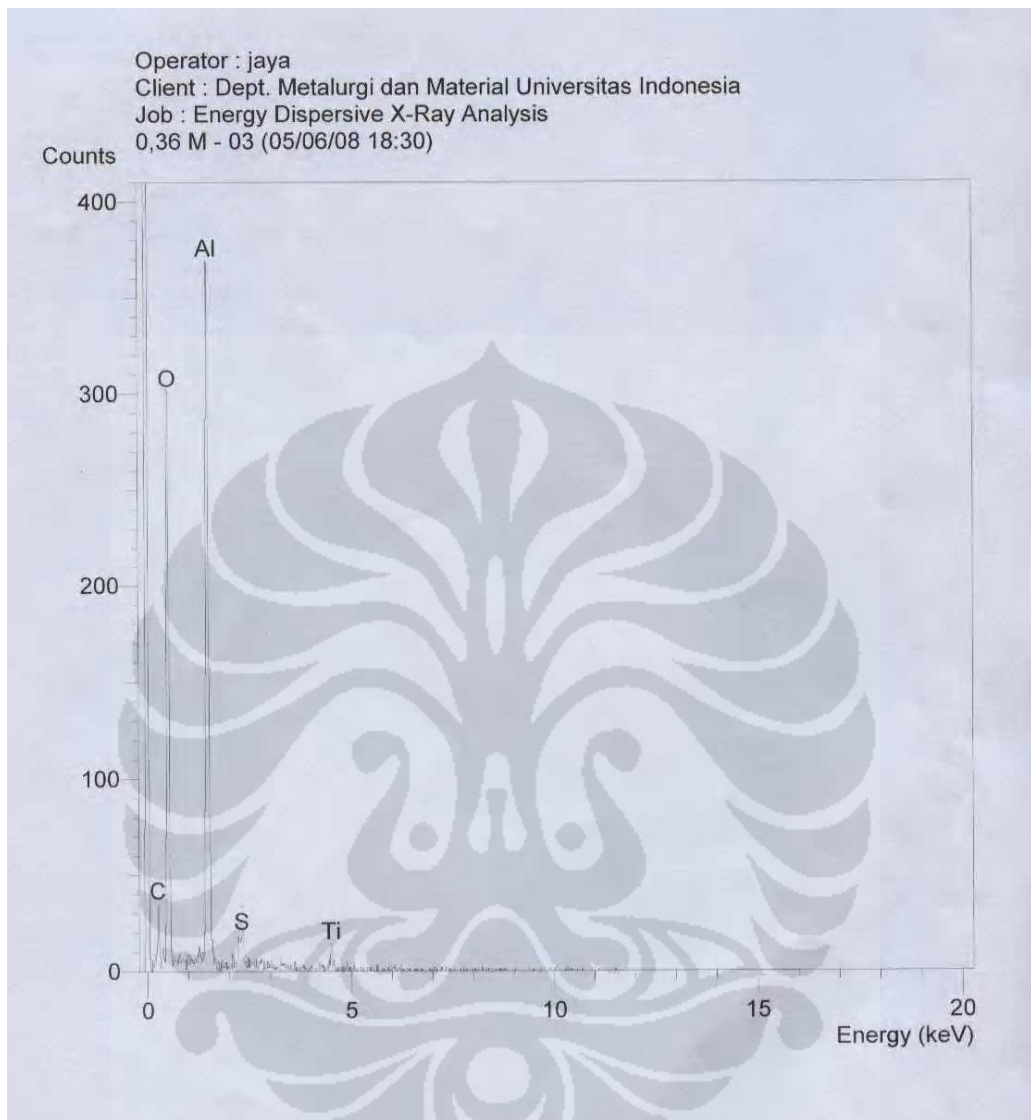
Lampiran 5. Kurva EDX sample hasil percobaan dengan penambahan 0,36 M Asam Sulfat (Bagian *Base Metal*)



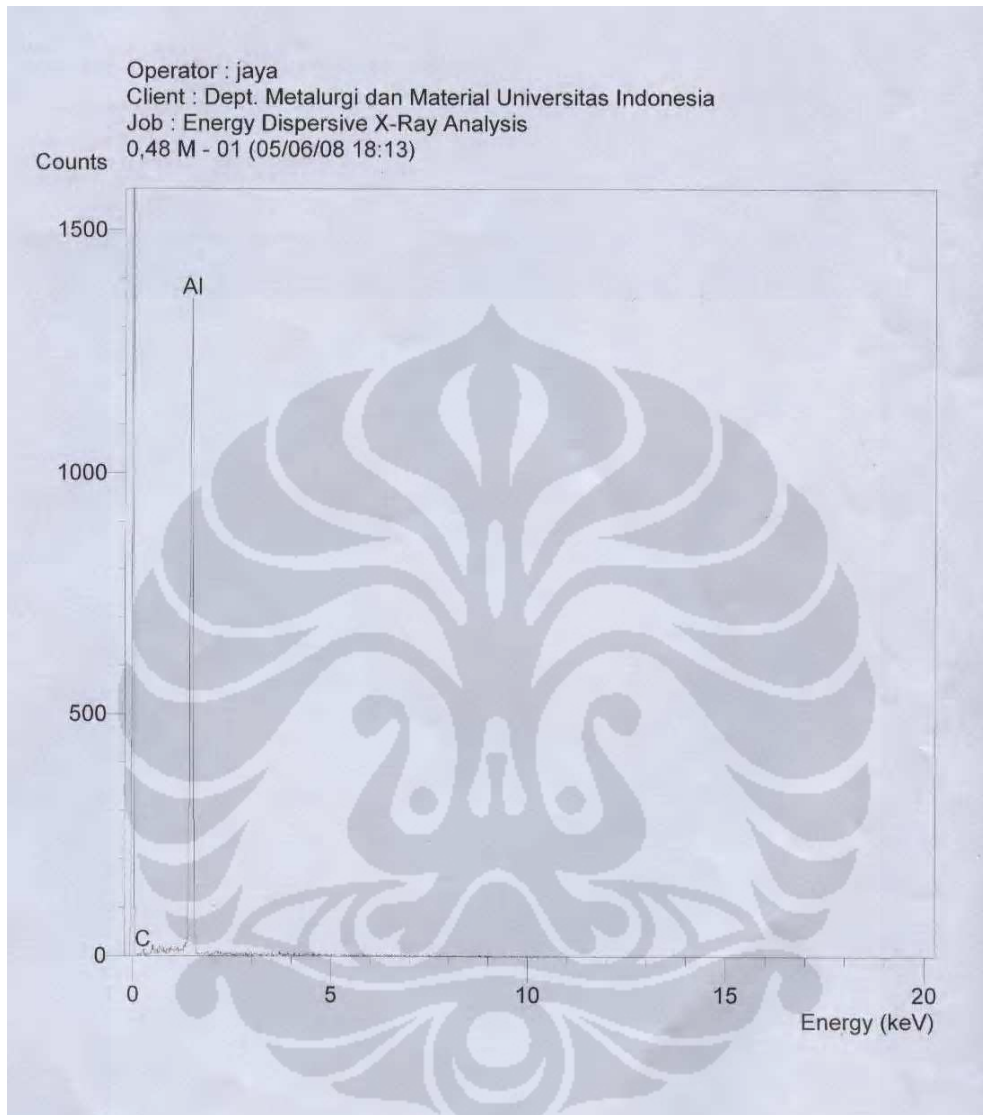
Lampiran 6. Kurva EDX sample hasil percobaan dengan penambahan 0,36 M Asam Sulfat (Bagian Lapisan Oksida I)



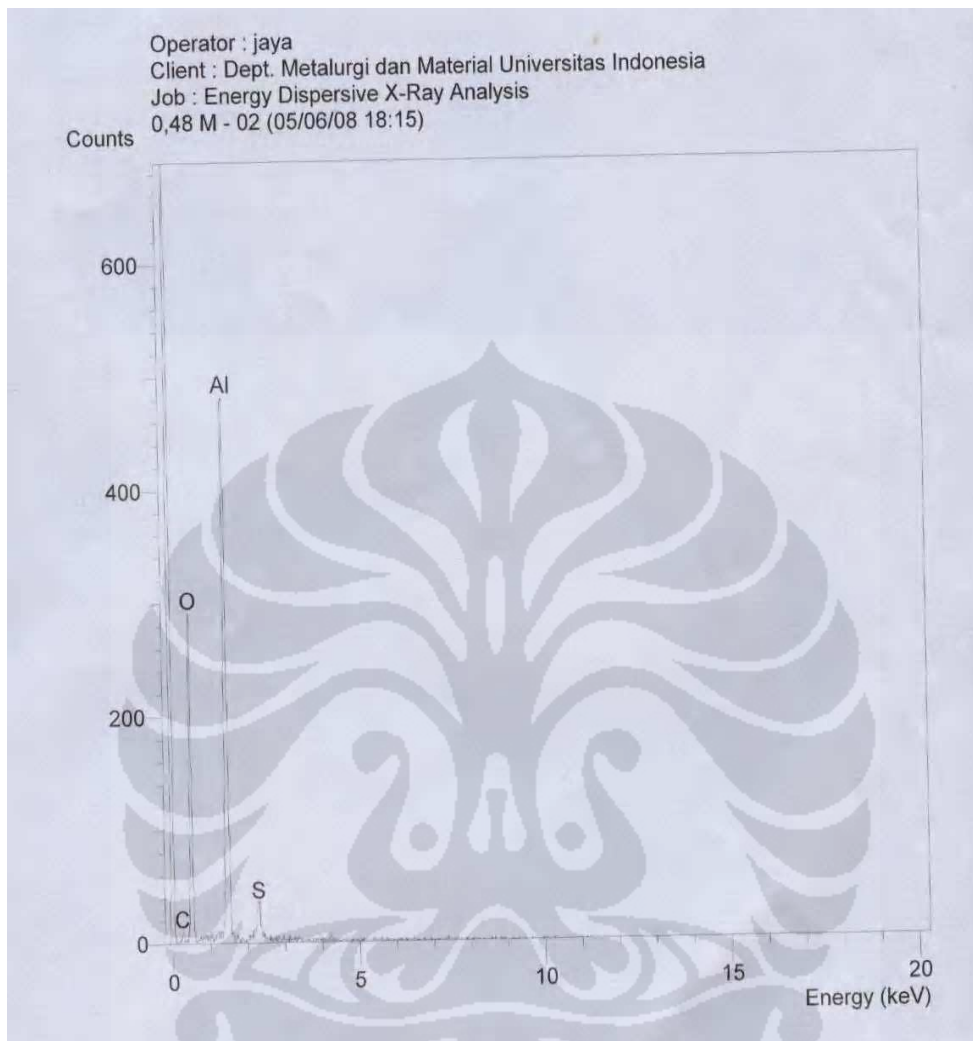
Lampiran 7. Kurva EDX sample hasil percobaan dengan penambahan 0,36 M Asam Sulfat (Bagian Lapisan Oksida II)



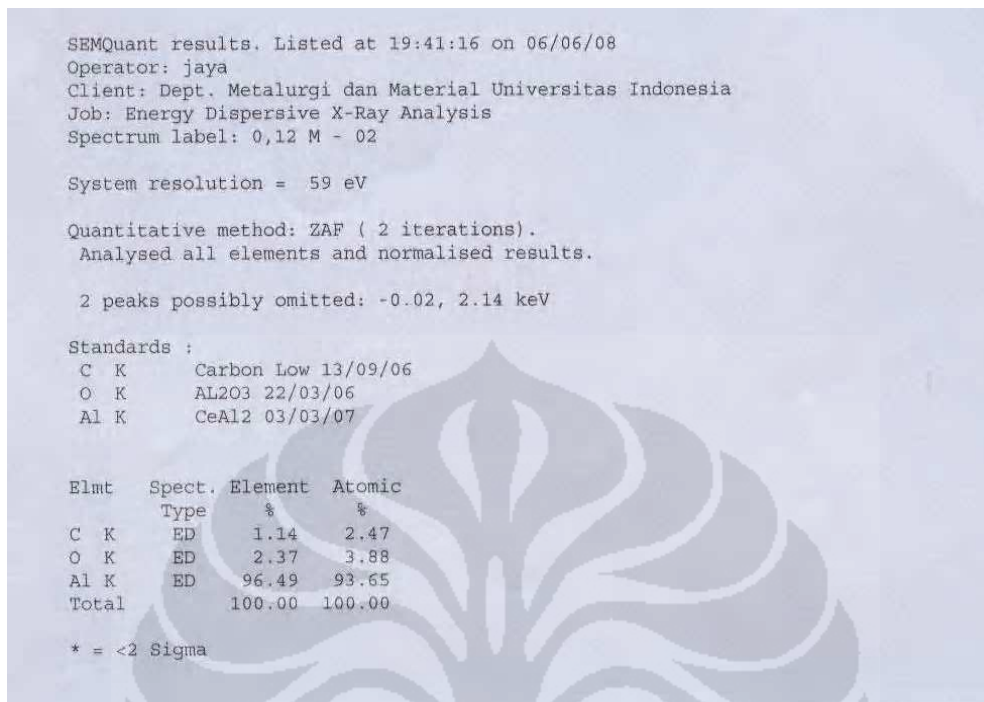
Lampiran 8. Kurva EDX sample hasil percobaan dengan penambahan 0,48 M Asam Sulfat (Bagian *Base Metal*)



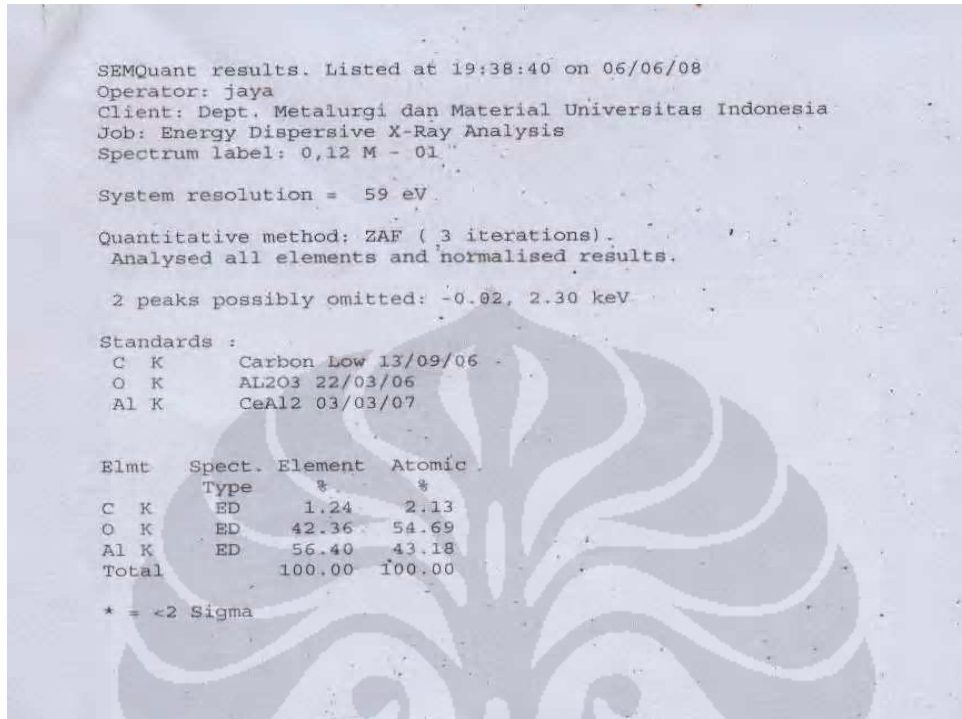
Lampiran 9. Kurva EDX sample hasil percobaan dengan penambahan 0,48 M Asam Sulfat (Bagian Lapisan Oksida)



Lampiran 10. Komposisi Hasil EDX sample hasil percobaan dengan penambahan 0,12 M Asam Sulfat (Bagian Lapisan Oksida)



Lampiran 11. Komposisi Hasil EDX sample hasil percobaan dengan penambahan 0,12 M Asam Sulfat (Bagian *Base Metal*)



SEMQuant results. Listed at 19:38:40 on 06/06/08
Operator: jaya
Client: Dept. Metalurgi dan Material Universitas Indonesia
Job: Energy Dispersive X-Ray Analysis
Spectrum label: 0,12 M - 01

System resolution = 59 eV

Quantitative method: ZAF (3 iterations).
Analysed all elements and normalised results.

2 peaks possibly omitted: -0.02, 2.30 keV

Standards :

C K	Carbon Low	13/09/06
O K	AL2O3	22/03/06
Al K	CeAl2	03/03/07

Elmt	Spect.	Element	Atomic
	Type	%	%
C K	ED	1.24	2.13
O K	ED	42.36	54.69
Al K	ED	56.40	43.18
Total		100.00	100.00

* = <2 Sigma

Lampiran 12. Komposisi Hasil EDX sample hasil percobaan dengan penambahan 0,24 M Asam Sulfat (Bagian Lapisan Oksida)

```
SEMQuant results. Listed at 20:01:07 on 06/06/08
Operator: jaya
Client: Dept. Metalurgi dan Material Universitas Indonesia
Job: Energy Dispersive X-Ray Analysis
Spectrum label: 0,24 M - 1

System resolution = 61 eV

Quantitative method: ZAF ( 3 iterations).
Analysed all elements and normalised results.

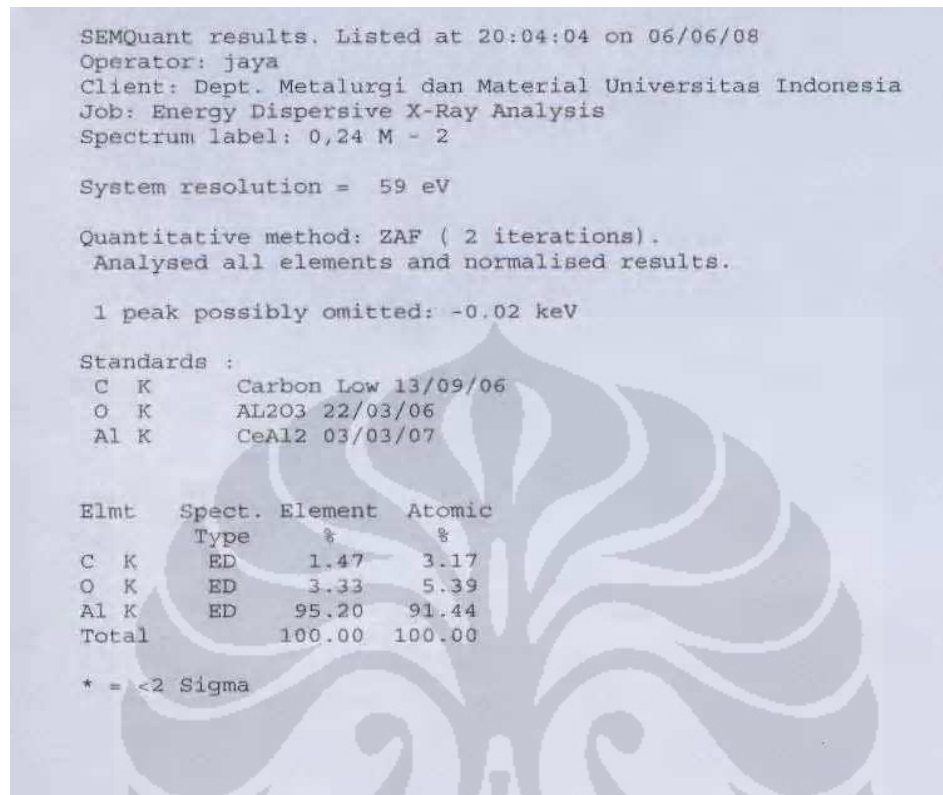
5 peaks possibly omitted: -0.02, 2.82, 3.32,
3.70, 4.50 keV

Standards :
C K      Carbon Low 13/09/06
O K      AL2O3 22/03/06
Al K     CeAl2 03/03/07
S K      FeS2 22/03/06

Elmt  Spect. Element  Atomic
      Type      %          %
C K   ED       1.86      3.18
O K   ED       43.75     56.09
Al K  ED       49.24     37.44
S K   ED       5.15      3.29
Total      100.00   100.00

* = <2 Sigma
```

Lampiran 13. Komposisi Hasil EDX sample hasil percobaan dengan penambahan 0,24 M Asam Sulfat (Bagian *Base Metal*)



Lampiran 14. Komposisi Hasil EDX sample hasil percobaan dengan penambahan
0,36 M Asam Sulfat (Bagian *Base Metal*)

```
SEMQuant results. Listed at 18:39:17 on 05/06/08
Operator: jaya
Client: Dept. Metalurgi dan Material Universitas Indonesia
Job: Energy Dispersive X-Ray Analysis
Spectrum label: 0,36 M - 01

System resolution = 59 eV

Quantitative method: ZAF ( 2 iterations).
Analysed all elements and normalised results.

1 peak possibly omitted: -0.02 keV

Standards :
C K      Carbon Low 13/09/06
Al K     CeAl2 03/03/07

Elmt  Spect. Element  Atomic
      Type        %        %
C K   ED          32.99  52.52
Al K   ED          67.01  47.48
Total                100.00 100.00

* = <2 Sigma
```

Lampiran 15. Komposisi Hasil EDX sample hasil percobaan dengan penambahan 0,36 M Asam Sulfat (Bagian Lapisan Oksida I)

```
SEMQuant results. Listed at 18:35:32 on 05/06/08
Operator: jaya
Client: Dept. Metalurgi dan Material Universitas Indonesia
Job: Energy Dispersive X-Ray Analysis
Spectrum label: 0,36 M - 02

System resolution = 61 eV

Quantitative method: ZAF ( 3 iterations).
Analysed all elements and normalised results.

Standards :
C K      Carbon Low 13/09/06
O K      AL2O3 22/03/06
Al K     CeAl2 03/03/07
S K      FeS2 22/03/06
```

Elmt	Spect. Type	Element %	Atomic %
C K	ED	10.34	16.56
O K	ED	41.08	49.40
Al K	ED	43.28	30.86
S K	ED	5.30	3.18
Total		100.00	100.00

* = <2 Sigma

Lampiran 16. Komposisi Hasil EDX sample hasil percobaan dengan penambahan 0,36 M Asam Sulfat (Bagian Lapisan Oksida II)

```
SEMQuant results. Listed at 18:34:03 on 05/06/08
Operator: jaya
Client: Dept. Metalurgi dan Material Universitas Indonesia
Job: Energy Dispersive X-Ray Analysis
Spectrum label: 0,36 M - 03

System resolution = 61 eV

Quantitative method: ZAF ( 3 iterations).
Analysed all elements and normalised results.

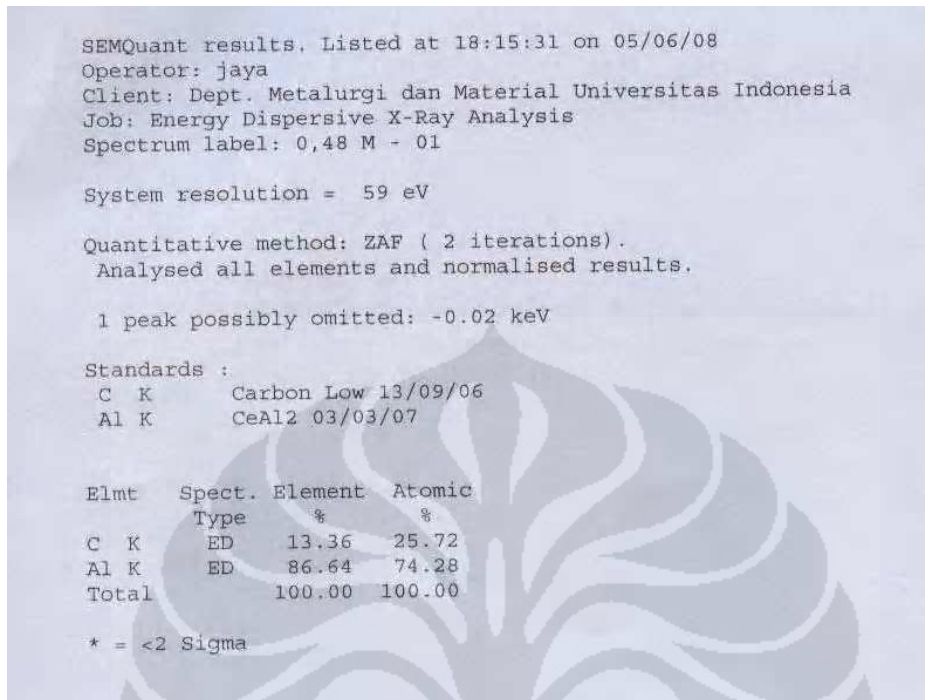
1 peak possibly omitted: -0.02 keV

Standards :
C K      Carbon Low 13/09/06
O K      AL2O3 22/03/06
Al K     CeAl2 03/03/07
S K      FeS2 22/03/06
Ti K     Titanium Oxide 19/05/06

Elmt  Spect. Element  Atomic
      Type      %      %
C K   ED      11.14  17.48
O K   ED      47.23  55.61
Al K  ED      32.55  22.72
S K   ED       3.17   1.86
Ti K  ED       5.91   2.33
Total      100.00 100.00

* = <2 Sigma
```


Lampiran 17. Komposisi Hasil EDX sample hasil percobaan dengan penambahan
0,48 M Asam Sulfat (Bagian *Base Metal*)



Lampiran 18. Komposisi Hasil EDX sample hasil percobaan dengan penambahan 0,48 M Asam Sulfat (Bagian Lapisan Oksida)

```
SEMQuant results. Listed at 18:17:08 on 05/06/08
Operator: jaya
Client: Dept. Metalurgi dan Material Universitas Indonesia
Job: Energy Dispersive X-Ray Analysis
Spectrum label: 0,48 M - 02

System resolution = 61 eV

Quantitative method: ZAF ( 3 iterations).
Analysed all elements and normalised results.

Standards :
C K Carbon Low 13/09/06
O K AL2O3 22/03/06
Al K CeAl2 03/03/07
S K FeS2 22/03/06

Elmt Spect. Element Atomic
Type % %
C K ED 9.70 15.64
O K ED 40.83 49.44
Al K ED 44.18 31.72
S K ED 5.30 3.20
Total 100.00 100.00

* = <2 Sigma
```